

MC100LVEL32

3.3 V ECL ÷2 Divider

Description

The MC100LVEL32 is an integrated ÷2 divider. The LVEL32 is functionally identical to the EL32, but operates from a 3.3 V supply.

The reset pin is asynchronous and is asserted on the rising edge. Upon power-up, the internal flip-flop will attain a random state; the reset allows for the synchronization of multiple LVEL32's in a system.

The V_{BB} pin, an internally generated voltage supply, is available to this device only. For single-ended input conditions, the unused differential input is connected to V_{BB} as a switching reference voltage. V_{BB} may also rebias AC coupled inputs. When used, decouple V_{BB} and V_{CC} via a 0.01 μ F capacitor and limit current sourcing or sinking to 0.5 mA. When not used, V_{BB} should be left open.

Features

- 510 ps Propagation Delay
- 2.6 GHz Typical Maximum Frequency
- ESD Protection:
 - ◆ > 4 KV Human Body Model
 - ◆ > 200 V Machine Model
- The 100 Series Contains Temperature Compensation
- PECL Mode Operating Range:
 - $V_{CC} = 3.0$ V to 3.8 V with $V_{EE} = 0$ V
- NECL Mode Operating Range:
 - $V_{CC} = 0$ V with $V_{EE} = -3.0$ V to -3.8 V
- Internal Input Pulldown Resistors
- Meets or Exceeds JEDEC Spec EIA/JESD78 IC Latchup Test
- Moisture Sensitivity:
 - ◆ Level 1 for SOIC-8
 - ◆ Level 3 for TSSOP-8
 - ◆ Level 1 for DFN-8
 - ◆ For Additional Information, see Application Note [AND8003/D](#)
- Flammability Rating: UL 94 V-0 @ 0.125 in, Oxygen Index: 28 to 34
- Transistor Count = 111 Devices
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant



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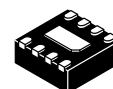
www.onsemi.com



SOIC-8 NB
D SUFFIX
CASE 751-07

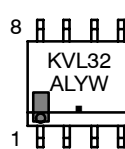


TSSOP-8
DT SUFFIX
CASE 948R-02

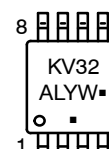


DFN-8
MN SUFFIX
CASE 506AA

MARKING DIAGRAMS*



SOIC-8 NB



TSSOP-8



DFN-8

- A = Assembly Location
- L = Wafer Lot
- Y = Year
- W = Work Week
- M = Date Code
- = Pb-Free Package

(Note: Microdot may be in either location)

*For additional marking information, refer to Application Note [AND8002/D](#).

ORDERING INFORMATION

| Device | Package | Shipping† |
|------------------|---------------------|------------------|
| MC100LVEL32DG | SOIC-8 NB (Pb-Free) | 98 Units / Tube |
| MC100LVEL32DR2G | SOIC-8 NB (Pb-Free) | 2500 Tape & Reel |
| MC100LVEL32DTG | TSSOP-8 (Pb-Free) | 100 Units / Tube |
| MC100LVEL32DTR2G | TSSOP-8 (Pb-Free) | 2500 Tape & Reel |
| MC100LVEL32MNR4G | DFN-8 (Pb-Free) | 1000 Tape & Reel |

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, [BRD8011/D](#).

MC100LEVEL32

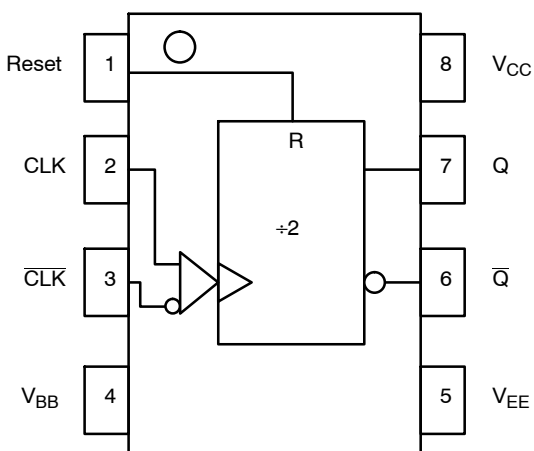


Figure 1. Logic Diagram and Pinout Assessment

Table 1. PIN DESCRIPTION

| Pin | Function |
|------------------------------------|--|
| CLK*, $\overline{\text{CLK}}^{**}$ | ECL Differential Clock Inputs |
| Q, $\overline{\text{Q}}$ | ECL Differential Data ± 2 Outputs |
| Reset* | ECL Asynch Reset |
| V_{BB} | Reference Voltage Output |
| V_{CC} | Positive Supply |
| V_{EE} | Negative Supply |
| EP | (DFN8 only) Thermal exposed pad must be connected to a sufficient thermal conduit. Electrically connect to the most negative supply (GND) or leave unconnected, floating open. |

*Pin will default low when left open, per internal 75 K pull-down to V_{EE} .

** Pin will default to $V_{\text{CC}}/2$ when left open per internal 75 K Ω pull-down to V_{EE} and 75 K Ω pull-up to V_{CC} .

Table 2. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
|----------------------|--|--|--|--------------------|-----------------------------|
| V_{CC} | PECL Mode Power Supply | $V_{\text{EE}} = 0 \text{ V}$ | | 8 to 0 | V |
| V_{EE} | NECL Mode Power Supply | $V_{\text{CC}} = 0 \text{ V}$ | | -8 to 0 | V |
| V_{I} | PECL Mode Input Voltage NECL Mode Input Voltage | $V_{\text{EE}} = 0 \text{ V}$ $V_{\text{CC}} = 0 \text{ V}$ | $V_{\text{I}} \leq V_{\text{CC}}$ $V_{\text{I}} \geq V_{\text{EE}}$ | 6 to 0 -6 to 0 | V |
| V_{I} | PECL Mode Input Voltage NECL Mode Input Voltage | $V_{\text{EE}} = 0 \text{ V}$ $V_{\text{CC}} = 0 \text{ V}$ | $V_{\text{I}} \leq V_{\text{CC}}$ $V_{\text{I}} \geq V_{\text{EE}}$ | 6 to 0 -6 to 0 | V |
| I_{out} | Output Current | Continuous Surge | | 50 100 | mA |
| I_{BB} | V_{BB} Sink/Source | | | ± 0.5 | mA |
| T_{A} | Operating Temperature Range | | | -40 to +85 | $^{\circ}\text{C}$ |
| T_{stg} | Storage Temperature Range | | | -65 to +150 | $^{\circ}\text{C}$ |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | SOIC-8 NB SOIC-8 NB | 190 130 | $^{\circ}\text{C}/\text{W}$ |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | SOIC-8 NB | 41 to 44 $\pm 5\%$ | $^{\circ}\text{C}/\text{W}$ |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | TSSOP-8 TSSOP-8 | 185 140 | $^{\circ}\text{C}/\text{W}$ |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | Standard Board | TSSOP-8 | 41 to 44 $\pm 5\%$ | $^{\circ}\text{C}/\text{W}$ |
| θ_{JA} | Thermal Resistance (Junction-to-Ambient) | 0 lfpm 500 lfpm | DFN-8 DFN-8 | 129 84 | $^{\circ}\text{C}/\text{W}$ |
| T_{sol} | Wave Solder (Pb-Free) | < 2 to 3 sec @ 260 $^{\circ}\text{C}$ | | 265 | $^{\circ}\text{C}$ |
| θ_{JC} | Thermal Resistance (Junction-to-Case) | (Note 1) | DFN-8 | 35 to 40 | $^{\circ}\text{C}/\text{W}$ |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. JEDEC standard multilayer board – 2S2P (2 signal, 2 power)

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Table 3. LVPECL DC CHARACTERISTICS ($V_{CC} = 3.3\text{ V}$; $V_{EE} = 0.0\text{ V}$ (Note 1))

| Symbol | Characteristic | -40°C | | | 25°C | | | 85°C | | | Unit |
|-------------|---|-------------|------|------------|-------------|------|------------|-------------|------|------------|---------------|
| | | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | |
| I_{EE} | Power Supply Current | | 29 | 35 | | 29 | 35 | | 31 | 36 | mA |
| V_{OH} | Output HIGH Voltage (Note 2) | 2215 | 2295 | 2420 | 2275 | 2345 | 2420 | 2275 | 2345 | 2420 | mV |
| V_{OL} | Output LOW Voltage (Note 2) | 1470 | 1605 | 1745 | 1490 | 1595 | 1680 | 1490 | 1595 | 1680 | mV |
| V_{IH} | Input HIGH Voltage (Single-Ended) | 2135 | | 2420 | 2135 | | 2420 | 2135 | | 2420 | mV |
| V_{IL} | Input LOW Voltage (Single-Ended) | 1490 | | 1825 | 1490 | | 1825 | 1490 | | 1825 | mV |
| V_{BB} | Output Voltage Reference | 1.92 | | 2.04 | 1.92 | | 2.04 | 1.92 | | 2.04 | V |
| V_{IHCMR} | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) $V_{PP} < 500\text{ mV}$ $V_{PP} \geq 500\text{ mV}$ | 1.2 1.4 | | 3.1 3.1 | 1.1 1.3 | | 3.1 3.1 | 1.1 1.3 | | 3.1 3.1 | V |
| I_{IH} | Input HIGH Current | | | 150 | | | 150 | | | 150 | μA |
| I_{IL} | Input LOW Current CLK CLK | 0.5 -600 | | | 0.5 -600 | | | 0.5 -600 | | | μA |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary $\pm 0.3\text{ V}$.
2. Outputs are terminated through a $50\ \Omega$ resistor to $V_{CC} - 2.0\text{ V}$.
3. V_{IHCMR} min varies 1:1 with V_{EE} , max varies 1:1 with V_{CC} . The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between V_{PPmin} and 1 V .

Table 4. LVNECL DC CHARACTERISTICS ($V_{CC} = 0.0\text{ V}$; $V_{EE} = -3.3\text{ V}$ (Note 1))

| Symbol | Characteristic | -40°C | | | 25°C | | | 85°C | | | Unit |
|-------------|---|--------------|-------|--------------|--------------|-------|--------------|--------------|-------|--------------|---------------|
| | | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | |
| I_{EE} | Power Supply Current | | 29 | 35 | | 29 | 35 | | 31 | 36 | mA |
| V_{OH} | Output HIGH Voltage (Note 2) | -1085 | -1005 | -880 | -1025 | -955 | -880 | -1025 | -955 | -880 | mV |
| V_{OL} | Output LOW Voltage (Note 2) | -1830 | -1695 | -1555 | -1810 | -1705 | -1620 | -1810 | -1705 | -1620 | mV |
| V_{IH} | Input HIGH Voltage (Single-Ended) | -1165 | | -880 | -1165 | | -880 | -1165 | | -880 | mV |
| V_{IL} | Input LOW Voltage (Single-Ended) | -1810 | | -1475 | -1810 | | -1475 | -1810 | | -1475 | mV |
| V_{BB} | Output Voltage Reference | -1.38 | | -1.26 | -1.38 | | -1.26 | -1.38 | | -1.26 | V |
| V_{IHCMR} | Input HIGH Voltage Common Mode Range (Differential Configuration) (Note 3) $V_{PP} < 500\text{ mV}$ $V_{PP} \geq 500\text{ mV}$ | -2.1 -1.9 | | -0.2 -0.2 | -2.1 -1.9 | | -0.2 -0.2 | -2.1 -1.9 | | -0.2 -0.2 | V |
| I_{IH} | Input HIGH Current | | | 150 | | | 150 | | | 150 | μA |
| I_{IL} | Input LOW Current CLK CLK | 0.5 -600 | | | 0.5 -600 | | | 0.5 -600 | | | μA |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary 1:1 with V_{CC} . V_{EE} can vary $\pm 0.3\text{ V}$.
2. Outputs are terminated through a $50\ \Omega$ resistor to $V_{CC} - 2.0\text{ V}$.
3. V_{IHCMR} min varies 1:1 with V_{EE} , max varies 1:1 with V_{CC} . The V_{IHCMR} range is referenced to the most positive side of the differential input signal. Normal operation is obtained if the HIGH level falls within the specified range and the peak-to-peak voltage lies between V_{PPmin} and 1 V .

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Table 5. AC CHARACTERISTICS ($V_{CC} = 3.3\text{ V}$; $V_{EE} = 0.0\text{ V}$ or $V_{CC} = 0.0\text{ V}$; $V_{EE} = -3.3\text{ V}$ (Note 1))

| Symbol | Characteristic | -40°C | | | 25°C | | | 85°C | | | Unit |
|------------------------|--|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|-------------------|------|
| | | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max | |
| f_{\max} | Maximum Toggle Frequency | 2.2 | 2.5 | | 2.4 | 2.6 | | 2.6 | 2.8 | | GHz |
| t_{PLH} t_{PHL} | Propagation Delay CLK to Q (Differential) CLK to Q (Single-Ended) Reset to Q | 350 300 440 | 500 500 555 | 530 580 640 | 370 320 450 | 510 510 540 | 550 600 650 | 410 360 480 | 540 540 580 | 590 640 680 | ps |
| t_{RR} | Reset Recovery | 175 | 50 | | 175 | 50 | | 175 | 50 | | ps |
| t_{PW} | Minimum Pulse Width Reset | 500 | 300 | | 500 | 300 | | 500 | 300 | | ps |
| t_{JITTER} | Random Clock Jitter (RMS) | | 2.0 | | | 2.0 | | | 2.0 | | ps |
| V_{PP} | Input Swing (Differential Swing) (Note 2) | 150 | | 1000 | 150 | | 1000 | 150 | | 1000 | mV |
| t_r t_f | Output Rise / Fall Times Q (20%–80%) | 120 | 225 | 320 | 120 | 225 | 320 | 120 | 225 | 320 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. V_{EE} can vary $\pm 0.3\text{ V}$.
2. $V_{PP}(\min)$ is input swing measured single-ended on each input in differential configuration.

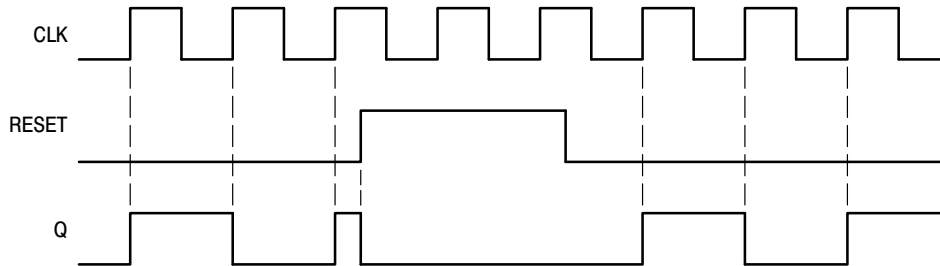


Figure 1. Timing Diagram

MC100LVEL32

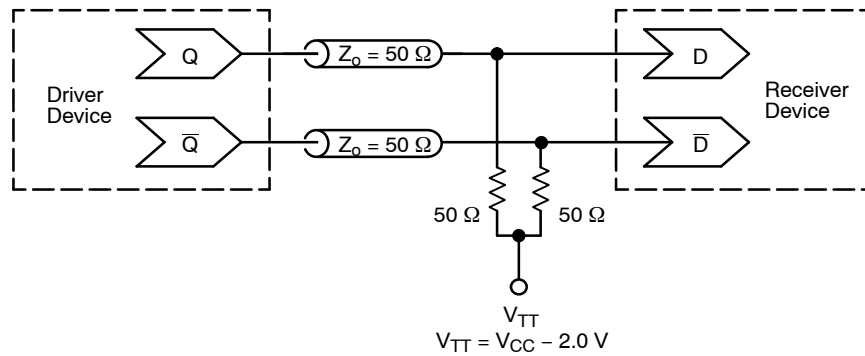


Figure 2. Typical Termination for Output Driver and Device Evaluation
(See Application Note [AND8020/D](#) – Termination of ECL Logic Devices)

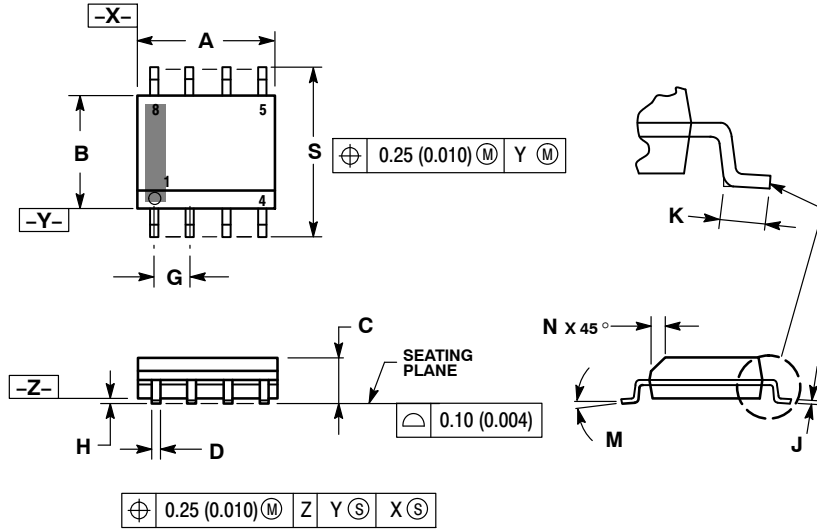
Resource Reference of Application Notes

- AN1405/D** – ECL Clock Distribution Techniques
- AN1406/D** – Designing with PECL (ECL at +5.0 V)
- AN1503/D** – ECLinPS I/O SPICE Modeling Kit
- AN1504/D** – Metastability and the ECLinPS Family
- AN1568/D** – Interfacing Between LVDS and ECL
- AN1672/D** – The ECL Translator Guide
- AND8001/D** – Odd Number Counters Design
- AND8002/D** – Marking and Date Codes
- AND8020/D** – Termination of ECL Logic Devices
- AND8066/D** – Interfacing with ECLinPS
- AND8090/D** – AC Characteristics of ECL Devices

MC100LEVEL32

PACKAGE DIMENSIONS

SOIC-8 NB
D SUFFIX
CASE 751-07
ISSUE AK

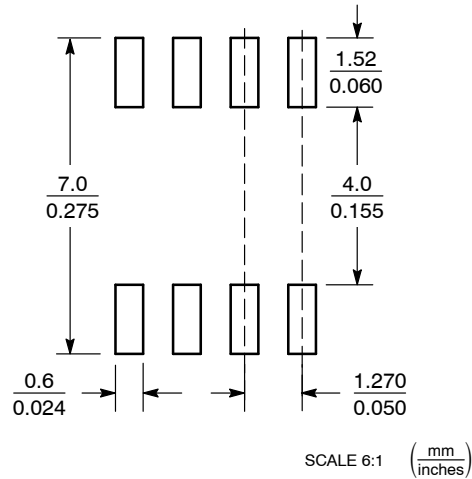


NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
4. MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE.
5. DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 4.80 | 5.00 | 0.189 | 0.197 |
| B | 3.80 | 4.00 | 0.150 | 0.157 |
| C | 1.35 | 1.75 | 0.053 | 0.069 |
| D | 0.33 | 0.51 | 0.013 | 0.020 |
| G | 1.27 BSC | | 0.050 BSC | |
| H | 0.10 | 0.25 | 0.004 | 0.010 |
| J | 0.19 | 0.25 | 0.007 | 0.010 |
| K | 0.40 | 1.27 | 0.016 | 0.050 |
| M | 0° | 8° | 0° | 8° |
| N | 0.25 | 0.50 | 0.010 | 0.020 |
| S | 5.80 | 6.20 | 0.228 | 0.244 |

SOLDERING FOOTPRINT*

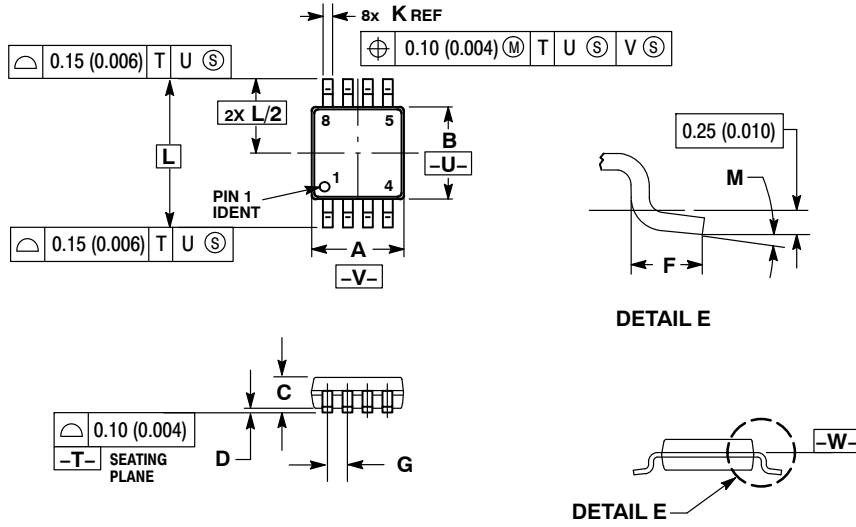


*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

MC100LVEL32

PACKAGE DIMENSIONS

TSSOP-8
DT SUFFIX
CASE 948R-02
ISSUE A



NOTES:

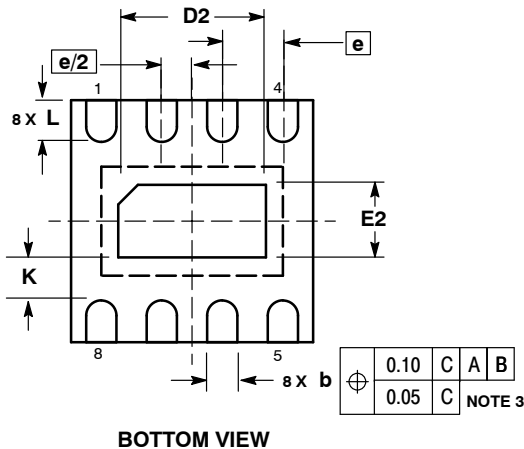
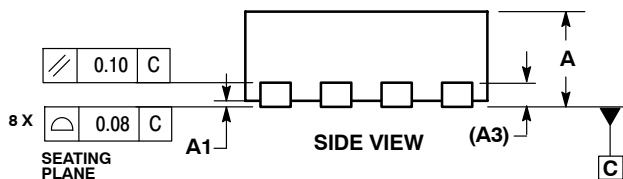
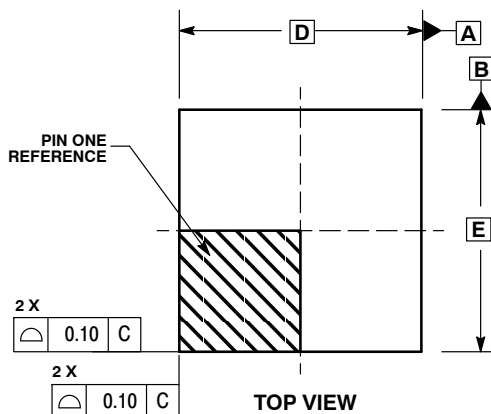
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: MILLIMETER.
3. DIMENSION A DOES NOT INCLUDE MOLD FLASH. PROTRUSIONS OR GATE BURRS. MOLD FLASH OR GATE BURRS SHALL NOT EXCEED 0.15 (0.006) PER SIDE.
4. DIMENSION B DOES NOT INCLUDE INTERLEAD FLASH OR PROTRUSION. INTERLEAD FLASH OR PROTRUSION SHALL NOT EXCEED 0.25 (0.010) PER SIDE.
5. TERMINAL NUMBERS ARE SHOWN FOR REFERENCE ONLY.
6. DIMENSION A AND B ARE TO BE DETERMINED AT DATUM PLANE -W-.

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|------|-----------|-------|
| | MIN | MAX | MIN | MAX |
| A | 2.90 | 3.10 | 0.114 | 0.122 |
| B | 2.90 | 3.10 | 0.114 | 0.122 |
| C | 0.80 | 1.10 | 0.031 | 0.043 |
| D | 0.05 | 0.15 | 0.002 | 0.006 |
| F | 0.40 | 0.70 | 0.016 | 0.028 |
| G | 0.65 BSC | | 0.026 BSC | |
| K | 0.25 | 0.40 | 0.010 | 0.016 |
| L | 4.90 BSC | | 0.193 BSC | |
| M | 0° | 6° | 0° | 6° |

MC100LVEL32

PACKAGE DIMENSIONS

DFN-8
MN SUFFIX
CASE 506AA
ISSUE D



NOTES:

1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994 .
2. CONTROLLING DIMENSION: MILLIMETERS.
3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM TERMINAL.
4. COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

| DIM | MILLIMETERS | |
|-----|-------------|------|
| | MIN | MAX |
| A | 0.80 | 1.00 |
| A1 | 0.00 | 0.05 |
| A3 | 0.20 REF | |
| b | 0.20 | 0.30 |
| D | 2.00 BSC | |
| D2 | 1.10 | 1.30 |
| E | 2.00 BSC | |
| E2 | 0.70 | 0.90 |
| e | 0.50 BSC | |
| K | 0.20 | --- |
| L | 0.25 | 0.35 |

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